

**Search Notes**

Application/Control No.

10/778,013

Examiner

Benny Lee

Applicant(s)/Patent under  
Reexamination

NGUYEN ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
333	238,246	4/22/2005	BTL
Rsch	above	10/19/2005	BTL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
333	238, 246	10/31/2005	BTL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR